Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/811,512	CHOI ET AL.
Examiner	Art Unit

2815

Edward Wojciechowicz

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Class	Subclass	Date	Examiner
257	510	11-28-05	CS1
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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